Notice of References Cited

Application/Control No. 10/609,443	Reexamination	Applicant(s)/Patent Under Reexamination CHOI ET AL.		
Examiner	Art Unit			
Helene Klemanski	1755	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0038073 A1	02-2004	Chebiam et al.	428/668
	В	US-2004/0035316 A1	02-2004	Chebiam et al.	106/1.22
	С	US-2003/0113576 A1	06-2003	Chebiam et al.	428/670
	D	US-6,197,364	03-2001	Paunovic et al.	427/132
	Ę	US-3,776,740	12-1973	Sivertz et al.	106/1.05
	F	US-4,005,229	01-1977	Miller et al.	427/304
	G	US-4,187,198	02-1980	Zeblisky, Rudolph J.	106/1.11
	Н	US-4,780,342	10-1988	LeBlanc, Jr., Oliver H.	427/443.1
	1	US-			
	J	US-			-
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р				,	
	Q					
	R				,	
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.



